## Application/Control No. Applicant(s)/Patent Under Reexamination 10/673,336 TANAKA ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 2821 Chuc D Tran **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY US-6,433,756 08-2002 Sievenpiper et al. 343/909 Α US-2003304113 10-2003 Tanaka Mokoto 343/700 MS В С US-6,262,495 07-2001 Yablonovitch et al. 307/101 D US-6,483,481 11-2002 Sievenpiper et al. 343/909 US-Ε US-F US-G US-Н US-1 J US-Κ US-US-L US-**FOREIGN PATENT DOCUMENTS** Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R S Т NON-PATENT DOCUMENTS Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W

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